

**Search Notes**

Application/Control No.

10/560,281

Examiner

Karen Cheng

Applicant(s)/Patent under  
Reexamination

TACHIBANA ET AL.

Art Unit

1626

**SEARCHED**

Class	Subclass	Date	Examiner
548	320.1	5/9/2007	KC
514	391	5/9/2007	KC
560	129	5/9/2007	KC
560	303	5/9/2007	KC

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
514	391	5/9/2007	KC
548	320.1	5/9/2007	KC
560	129, 303	5/9/2007	KC

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
STN Structure Search (updated, see attached)	5/9/2007	KC
EAST Search (see attached)	5/9/2007	KC